

Issue Classification		Application/Control No. 09/545,040	Applicant(s)/Patent under Reexamination COL ET AL.
		Examiner Aimee J. Li	Art Unit 2183

ISSUE CLASSIFICATION					
ORIGINAL		INTERNATIONAL CLASSIFICATION			
CLASS	SUBCLASS	CLAIMED			NON-CLAIMED
712	218	G	06	F 15 /00	/
CROSS REFERENCES				/	/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			/	/
				/	/
				/	/
				/	/
				/	/
<i>Aimee Li</i> (Assistant Examiner)	<i>3/28/2006</i> (Date)	<i>Eddie Chan</i> EDDIE CHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Examiner)	<i>3/28/2006</i> (Date)	Total Claims Allowed: 15	
<i>R. W. Yip</i> (Legal Instruments Examiner)	<i>3-3-06</i> (Date)	O.G. Print Claim(s) 1	O.G. Print Fig. 2		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5		6	35	65	95	125	155
6		7	36	66	96	126	156
7		8	37	67	97	127	157
8		9	38	68	98	128	158
9		10	39	69	99	129	159
10		11	40	70	100	130	160
11		12	41	71	101	131	161
12		13	42	72	102	132	162
13		14	43	73	103	133	163
14		15	44	74	104	134	164
15			45	75	105	135	165
16			46	76	106	136	166
17			47	77	107	137	167
18			48	78	108	138	168
19			49	79	109	139	169
20			50	80	110	140	170
1	21		51	81	111	141	171
2	22		52	82	112	142	172
23			53	83	113	143	173
24			54	84	114	144	174
25			55	85	115	145	175
26			56	86	116	146	176
27			57	87	117	147	177
28			58	88	118	148	178
29			59	89	119	149	179
3	30		60	90	120	150	180
							210